


<b>Search Notes</b>  	<b>Application/Control No.</b>  10580811	<b>Applicant(s)/Patent Under Reexamination</b>  NIJIM ET AL.
	<b>Examiner</b>  M. Lee	<b>Art Unit</b>  2622

SEARCHED			
Class	Subclass	Date	Examiner
348	383, 778, 739, 735, 805, 806, 807, 763, 687, 744	5/1/09	ml

SEARCH NOTES		
Search Notes	Date	Examiner
east	5/1/09	ml

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/M. Lee/ Primary Examiner.Art Unit 2622
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